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Effects of Pressure on the Band Structure of Highly Mismatched $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ Alloys

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We report photomodulation spectroscopy measurements of the pressure dependence of the optical transition in $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ alloys that is associated with the lowest Γ conduction band (termed E_- subband). The pressure-induced energy shift of the E_- transition is nonlinear and much weaker as compared to change of the direct band gap of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$. The weak pressure dependence of the E_- transition can be fully understood based on the band anticrossing model in which the E_- subband results from an interaction between the extended ZnMnTe conduction-band states and the localized O electronic states.

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The discovery of band anticrossing induced conduction band splitting caused by the strong interaction between the extended conduction band states and localized N resonant states in $\text{Ga}_{1-x}\text{In}_x\text{N}_y\text{As}_{1-y}$ alloys¹ has led to extensive studies on the properties of so-called highly mismatched alloys (HMAs) in which a small fraction of the constituent anion element is replaced by an element with highly dissimilar properties in terms of electronegativity and atomic size.²⁻¹⁰ The dramatic changes of the electronic properties caused by substitution of the group V element in group III-V compounds with small amounts of nitrogen at alloy-like concentrations, such as a pronounced reduction of the fundamental band-gap energy,^{11,12} a significant increase in electron effective mass and a decrease in electron mobility,^{7,13,14} as well as the appearance of a new optical transition (E_+) from the valence band to the conduction band at the Γ point,^{1,4,15} have been well explained by the band anticrossing (BAC) model.^{1,2}

The anticrossing interaction between the extended conduction-band states of a semiconductor matrix and the highly localized electronic states introduced by the isoelectronic substitutional atoms with high electronegativity, such as N in GaAs or O in ZnSe, can be expressed as^{1,2}

$$E_{\pm}(k) = \frac{1}{2} \left\{ \left(E_M(k) + E_D \right) \pm \sqrt{\left(E_M(k) - E_D \right)^2 + 4V^2} \right\}, \quad (1)$$

where $E_M(k)$ and E_D are the energies of the unperturbed conduction band and of the localized states relative to the top of the valence band, respectively. The matrix element describing the interaction and hybridization between the localized states and the extended conduction-band states $V = C_{MD}x^{1/2}$, where C_{MD} is a constant dependent on the semiconductor matrix and x is the alloy composition. The energy positions of the subband edges given by Eq.(1) depend on the interaction parameter V and the location of E_D with respect to the conduction band edge E_M . Illustrated in Fig. 1 are schematic examples of the calculated band structure based on the BAC

model. The interaction between the localized isoelectronic states and the extended conduction-band states has a pronounced effect on the dispersion relation of the two conduction subbands E_- and E_+ . If the localized state is located within the conduction band of the matrix, as depicted in Fig.1(a), the conduction-band states at the E_- edge retain mostly the extended E_M -like character and those at the E_+ edge are more of localized and E_D -like character. If the localized states lie below the conduction-band edge, as displayed in Fig.1(b), the conduction-subband edges E_- and E_+ switch their characters: the E_- subband states have the highly localized nature and E_+ subband states possess the character of extended state.

To date, most experimental studies have concentrated on the case of the localized state resonant with the conduction band, such as the well known case of $\text{GaN}_x\text{As}_{1-x}$. In this work, we address the case in which the localized state is located below the conduction band and within the forbidden gap of a semiconductor matrix. Specifically, we study the effect of applied pressure on the band structure of $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ alloys. We show that the formation of E_- and E_+ bands in $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ can be demonstrated experimentally and the characteristic signature of the E_- subband edge can be verified unmistakably by its pressure dependence.

The $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ samples used in this work are synthesized using O ion implantation followed by pulsed laser melting (PLM). This approach is very effective in incorporating impurities into a crystal to levels well above the solubility limit due to the rapid recrystallization rate.^{16,17} Synthesis of diluted $\text{GaN}_x\text{As}_{1-x}$,¹⁸ as well as ferromagnetic $\text{Ga}_{1-x}\text{Mn}_x\text{As}$ ¹⁹ using the PLM process has recently been demonstrated. Multiple energy implantation using 30 and 90 keV O^+ ions was carried out into $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ single crystals to form ~ 0.2 μm thick layers with relatively constant O concentrations corresponding to O mole fractions of 0.0165-0.044. The reason of using ternary ZnMnTe as substrates is that the presence of Mn enhances and stabilizes

the incorporation of O.⁸ The O⁺-implanted samples were pulsed-laser melted in air using a KrF laser ($\lambda = 248$ nm) with a pulse duration ~ 38 ns. After passing through a multi-prism homogenizer, the fluence at the sample ranged between 0.020 and 0.3 J/cm².

Photomodulation spectroscopy measurements were carried out to measure the energies of the optical transitions in the samples in both transmission (PT) and reflection (PR) configurations. Quasimonochromatic light from a Xenon arc lamp dispersed by a 0.5-m monochromator was focused on the samples as a probe beam. A chopped HeCd laser beam (3250 or 4420 Å) provided the photomodulation. The photomodulated spectral signals were detected by a Si photodiode using a phase-sensitive lock-in amplification system. Application of hydrostatic pressure was accomplished by mounting small sample chips with sizes of $\sim 200 \times 200$ μm^2 into a gasketed diamond anvil cell.

Figure 2 shows PR spectra taken at 80 K from two $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{O}_x\text{Te}_{1-x}$ samples implanted with 3.3% O⁺ followed by PLM with laser energy fluence of 0.15 and 0.3 J/cm², as well as from the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ used as the substrate in this work. The actual “active” O concentration (x) in the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{O}_x\text{Te}_{1-x}$ samples is estimated to be roughly around 1%.²⁰ However, its precise value is not very important in the discussion presented here. The derivative-like spectral feature in the PR spectrum of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ corresponds to the optical transition from the valence-band edge to the conduction-band edge. The band-gap energy is found to be 2.40 eV at 80 K for the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ matrix. For the oxygen containing samples, the PR spectra exhibit two features with energies distinctly different from the fundamental band gap of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ matrix. These two transitions are assigned to those from the top of the valence band to the two conduction subband edges, E_- (~ 1.85 eV) and E_+ (~ 2.6 eV), formed by the band anticrossing interaction between the localized O states and the extended conduction-band states

of ZnMnTe matrix as illustrated by Fig.1(b). The strong photomodulation signals of both E_- and E_+ indicate the band-to-band nature of these transitions and suggest that the E_- transition has substantial oscillator strength comparable to that of the E_+ transition.

To further elucidate the origin of the E_- band we have studied the effects of hydrostatic pressure on the E_- transition. The energy positions of the E_- transition in the sample treated by PLM with a laser energy fluence of 0.3 J/cm^2 has been measured as a function of applied hydrostatic pressure at room temperature. The results are shown in Fig. 3, along with the measured pressure dependence of the band gap of the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ matrix. The room-temperature energy position of the E_+ transition at atmospheric pressure is also shown in the figure. The inset shows a typical PT spectrum recorded at high pressures. By fitting the experimental data (open circles in Fig.3) to $\Delta E(P) = \alpha P$ with $\alpha = dE_g/dP$, the pressure dependence of the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ band gap is found to be $dE_g/dP = 8.5 \text{ meV/kbar}$. It is not surprising to see that the pressure-induced energy shift of the E_- transition is much weaker (initial slope $\approx 2 \text{ meV/kbar}$) and nonlinear as compared to change of the direct band gap of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$. The weak pressure dependence of the E_- transition can be fully understood with the BAC model. The fact that E_- is located much closer to the energy level of the localized O states [Fig.1(b)] gives its wavefunction a pronounced O-like character. The solid lines through the experimental data in Fig. 3 are the calculated pressure dependencies of E_- and E_+ transitions using Eq. (1). The best fits to the data yield the energy position of O level (relative to the top of the valence band) $E_O = E_V + 2.0 \pm 0.1 \text{ eV}$ at atmospheric pressure with a pressure dependence of $0.6 \pm 0.1 \text{ meV/kbar}$. It is clear from the figure that the pressure dependence of the E_- transition is slightly stronger than that of the O level as expected from the admixture of extended conduction-band Γ_C states of matrix to the E_- band-edge states. On the other hand, the much weaker pressure dependence of

the E_- transition as compared to that of the conduction-band Γ_C edge indicated the predominantly O-like nature of the E_- band.

The present results have important inferences for the understanding of the origin of the unusual electronic structure of HMAs. They show that the electronic structure of different HMAs can be explained by the BAC model with a common picture. They also provide strong arguments against other previously proposed models. It has been argued that the electronic structure of $\text{GaN}_x\text{As}_{1-x}$ alloys results from an interaction between the closely lying Γ_C , L_C , and X_C minima.²¹⁻
²³ The interaction is caused by the perturbation potential resultant from the substitution of N atom to As atom. In these models the smaller and pressure-dependent pressure coefficient of the E_- transition observed in $\text{GaN}_x\text{As}_{1-x}$ alloys was attributed to the increasing contribution of the L_C and X_C minima whose pressure coefficients are much smaller than that of the Γ_C minimum. Apparently, these models cannot explain the results presented here. The large downward shift of 0.5 eV of the conduction band minimum (E_-) and the very weak pressure dependence of the band energy as shown in Fig.3 cannot be attributed to the influence from the conduction-band L and X edges because they are located far away from the Γ_C edge (>1.0 eV) in $\text{Zn}_{1-y}\text{Mn}_y\text{Te}$.²⁴ Thus, our results directly confirm that the E_- transition together with the E_+ are the results of a band anticrossing interaction between the extended Γ conduction-band states and highly localized states in highly mismatched alloys.

In conclusion, we have studied the effect of pressure on the electronic band structure of $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ alloys by investigating the optical transitions associated with the Γ point at the conduction-band and the valence-band edges. The $\text{Zn}_{1-y}\text{Mn}_y\text{O}_x\text{Te}_{1-x}$ samples were found to exhibit a classical band-anticrossing behavior with the formation of two conduction subbands (E_- and E_+) resulting from the strong interaction between the extended conduction-band states of

$Zn_{1-y}Mn_yTe$ and the localized O states. By examining the effect of applied pressure on the E_- transition, we are able to derive the energetic position of $E_O = E_V + 2.0 \pm 0.1$ eV for the localized O level and its pressure dependence of 0.6 ± 0.1 meV/kbar from the experimental results.

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Figure Captions:

Figure 1. Illustration of the effects of band anticrossing on the Γ conduction band structure. (a) The highly electronegative isoelectronic impurity induced localized state resonant with the conduction band; (b) The localized state located below the conduction band. The solid lines are the restructured E_- and E_+ subbands resulting from the band anticrossing interaction between the localized states (dash-dotted line) and the extended states of the conduction band (broken line).

Figure 2. PR spectra taken from $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}_{1-x}\text{O}_x$ samples at 80 K compared with the PR curve of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ substrate.

Figure 3. Effect of pressure on the energy position of the E_- band edge of a $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}_{1-x}\text{O}_x$ sample (triangles). The change of the band gap of the $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}$ substrate with pressure is also displayed (open circle). The solid lines are theoretical fitting results. The dashed-dotted line is the location of E_O relative to the top of the valence band. The inset shows a typical PT spectrum of $\text{Zn}_{0.88}\text{Mn}_{0.12}\text{Te}_{1-x}\text{O}_x$ under pressure.

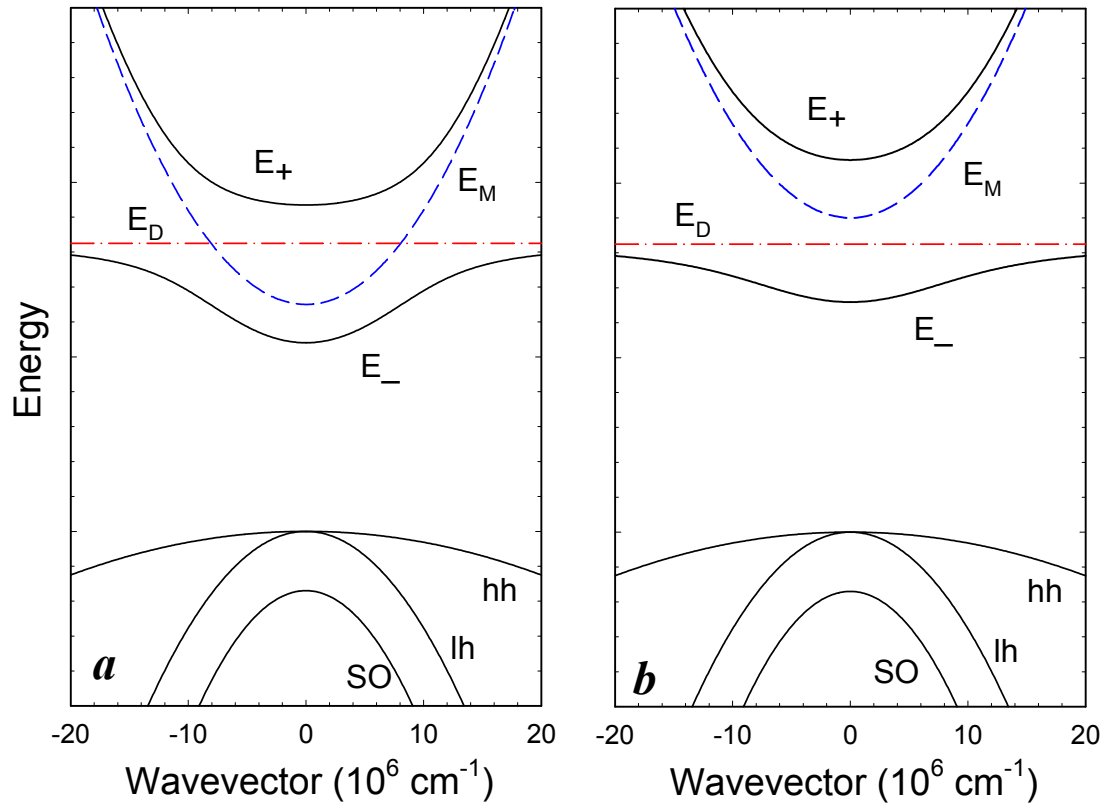


Figure 1/3

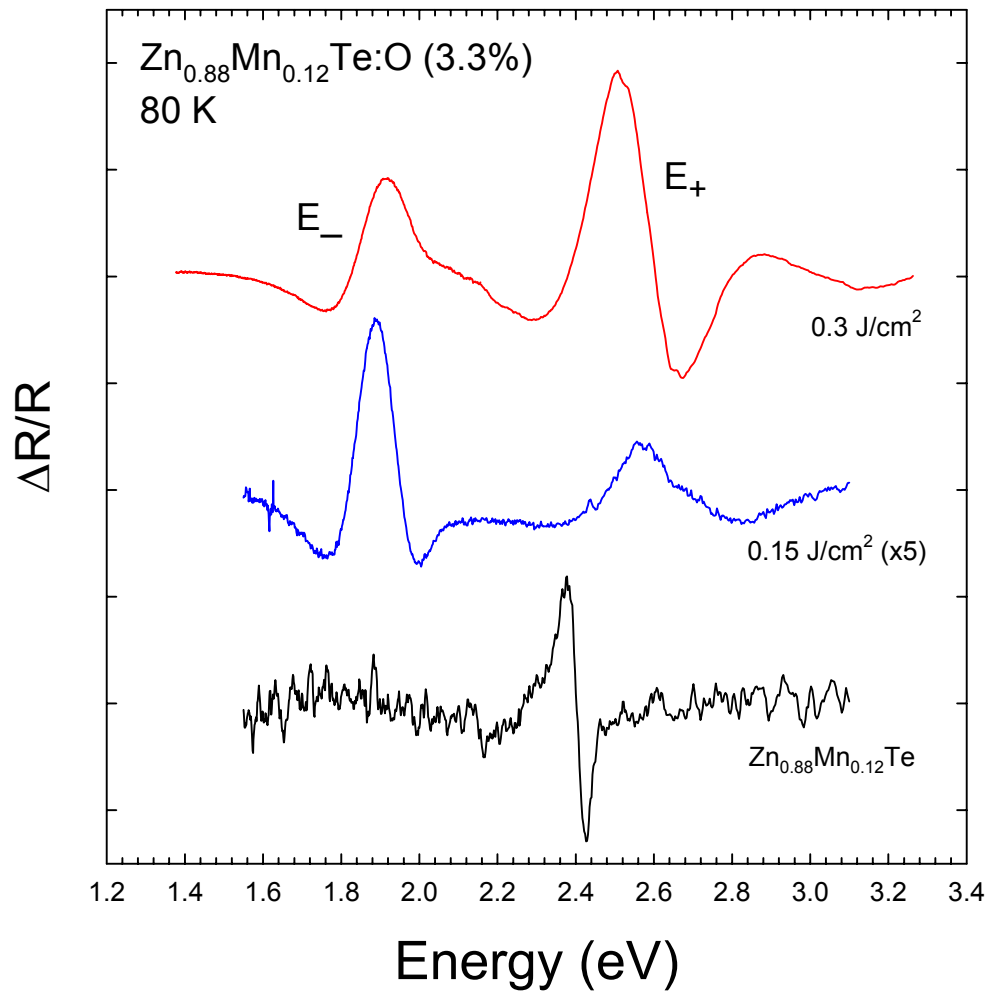


Figure 2/3

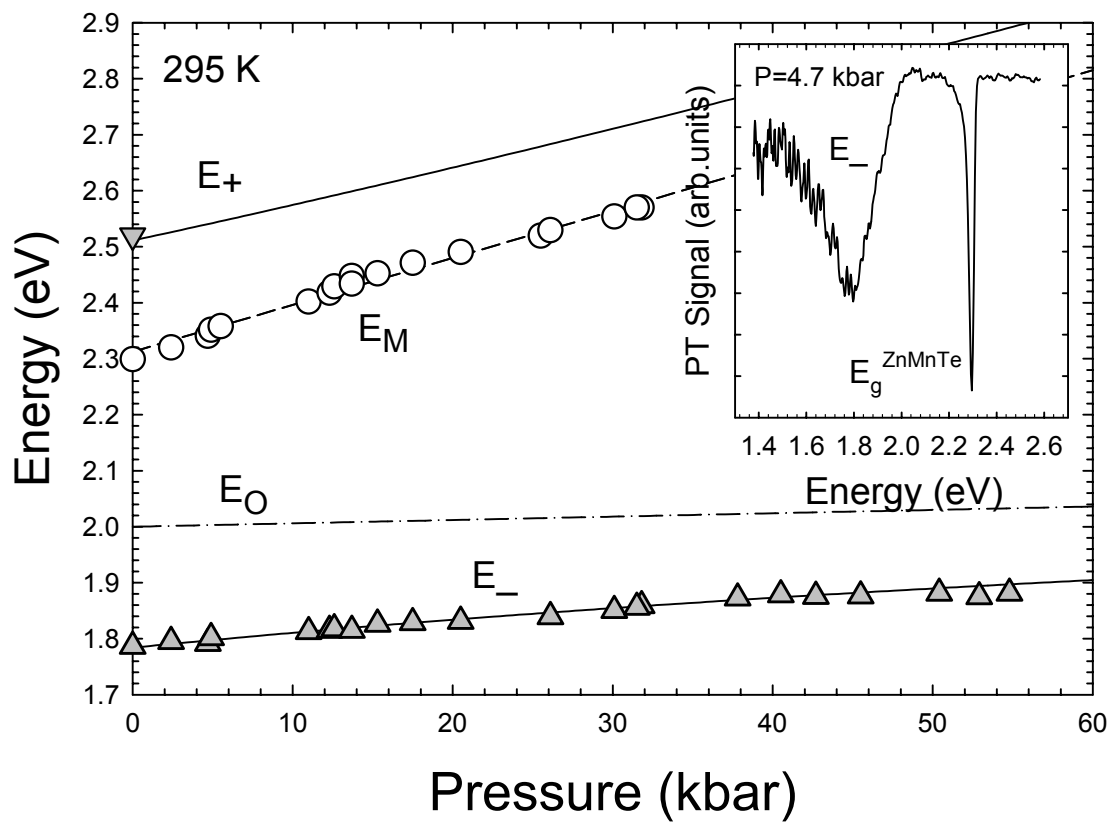


Figure 3/3